


<b>Search Notes</b>  	<b>Application/Control No.</b>  10522030	<b>Applicant(s)/Patent Under Reexamination</b>  CRITOPH ET AL.
	<b>Examiner</b>  EMILY I NALVEN	<b>Art Unit</b>  3744

SEARCHED			
Class	Subclass	Date	Examiner
62	467, 480, 112, 141, 142, 132, 147, 231, 232, 476, 479, 495	3/4/08	EIN

SEARCH NOTES		
Search Notes	Date	Examiner
EAST Search Notes Attached	3/4/08	EIN

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner